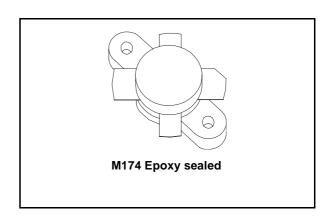


### SD2941-10

# RF power transistors HF/VHF/UHF N-channel MOSFETs

#### **General features**

- Gold metallization
- Excellent thermal stability
- Common source configuration
- P<sub>OUT</sub> = 175W min. with 15dB gain @ 175MHz
- Low R<sub>DS(on)</sub>
- Thermally enhanced packaging for lower junction temperatures

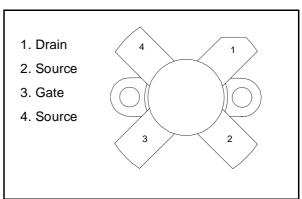


### **Description**

The SD2941-10 is a gold metallized N-Channel MOS field-effect RF power transistor, intended for use in 50 V dc large signal applications up to 230 MHz. It is offering 25% lower  $R_{DS(ON)}$  than industry standard, with 20% higher  $P_{SAT}$  than ST SD2931-10.

The SD2941-10 is housed in the low thermal nonpedestal package, offering 25 % lower thermal resistance than industry standard, thus representing the best-in-class transistors for ISM applications, where reliability and ruggedness are critical factors.

#### Pin connection



#### **Order codes**

Part number	Marking	Package	Packaging
SD2941-10	SD2941-10	M174	Plastic tray

April 2006 Rev 3 1/12

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SD2941-10 1 Electrical data

### 1 Electrical data

### 1.1 Maximum rating

Table 1. Absolute maximum rating  $(T_{CASE} = 25^{\circ}C)$ 

Symbol	Parameter	Value	Unit
V <sub>(BR)DSS</sub> <sup>(1)</sup>	Drain Source Voltage	130	V
V <sub>DGR</sub> <sup>(1)</sup>	Drain-Gate Voltage ( $R_{GS} = 1M\Omega$ )	130	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub>	Drain Current	20	Α
P <sub>DISS</sub>	Power Dissipation	389	W
TJ	Max. Operating Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C

<sup>1.</sup> T<sub>J</sub> = 150 °C

### 1.2 Thermal data

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thJC</sub>	Junction to Case thermal resistance	0.45	°C/W

1 Electrical data SD2941-10

### 1.3 Electrical characteristics $(T_{CASE} = 25^{\circ}C)$

Table 3. Static

Symbol		Test Conditions	Min.	Тур.	Max.	Unit	
V <sub>(BR)DSS</sub> <sup>(1)</sup>	V <sub>GS</sub> = 0 V	I <sub>DS</sub> = 100 mA	I <sub>DS</sub> = 100 mA				V
I <sub>DSS</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 50 V				50	μΑ
I <sub>GSS</sub>	V <sub>GS</sub> = 20 V	V <sub>DS</sub> = 0 V	V <sub>DS</sub> = 0 V			250	nA
V <sub>GS(Q)</sub> (2)	V <sub>DS</sub> = 10 V	$I_D = 250 \text{ mA}$			Table 5.		V
V <sub>DS(ON)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A				2.0	V
G <sub>FS</sub>	V <sub>DS</sub> = 10 V	I <sub>D</sub> = 5 A		5	6		mho
C <sub>ISS</sub>	V <sub>GS</sub> = 0 V	$V_{DS} = 50 \text{ V}$	f = 1 MHz		415		pF
C <sub>OSS</sub>	$V_{GS} = 0 V$	$V_{DS} = 50 \text{ V}$	f = 1 MHz		236		pF
C <sub>RSS</sub>	V <sub>GS</sub> = 0 V	$V_{DS} = 50 \text{ V}$	f = 1 MHz		17		pF

<sup>1.</sup>  $T_J = 150^{\circ}C$ 

Table 4. Dynamic

Symbol	Test Conditions	Min.	Тур.	Max.	Unit
P <sub>OUT</sub>	$V_{DD} = 50 \text{ V}$ $I_{DQ} = 250 \text{ mA}$ $f = 175 \text{MHz}$	175	200		W
G <sub>PS</sub>	$V_{DD} = 50 \text{ V}$ $I_{DQ} = 250 \text{ mA}$ $P_{OUT} = 175 \text{ W}$ $f = 175 \text{MHz}$	14	15.8		dB
h <sub>D</sub>	V <sub>DD</sub> = 50 V I <sub>DQ</sub> = 250 mA P <sub>OUT</sub> = 175 W f = 175MHz	55	65		%
Load Mismatch	$V_{DD}$ = 50 V $I_{DQ}$ = 250 mA $P_{OUT}$ = 175W $f$ = 175MHz All Phase Angles	10:1			VSWR

Table 5. V<sub>GS</sub> Sorts

Symbol	Value	Symbol	Value	Symbol	Value
AA	1.5 - 1.6	Е	2.4 - 2.5	Р	3.3 - 3.4
BB	1.6 - 1.7	F	2.5 - 2.6	Q	3.4 - 3.5
СС	1.7 - 1.8	G	2.6 - 2.7	R	3.5 - 3.6
DD	1.8 - 1.9	Н	2.7 - 2.8	S	3.6 - 3.7
EE	1.9 - 2.0	J	2.8 - 2.9	Т	3.7 - 3.8
А	2.0 - 2.1	K	2.9 - 3.0	U	3.8 - 3.9
В	2.1 - 2.2	L	3.0 - 3.1	V	3.9 - 4.0
С	2.2 - 2.3	М	3.1 - 3.2		
D	2.3 - 2.4	N	3.2 - 3.3		

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<sup>2.</sup>  $V_{GS(Q)}$  sorted with alpha/numeric code marked on unit

**SD2941-10** 2 Impedance

## 2 Impedance

Figure 1. Impedance data schematic

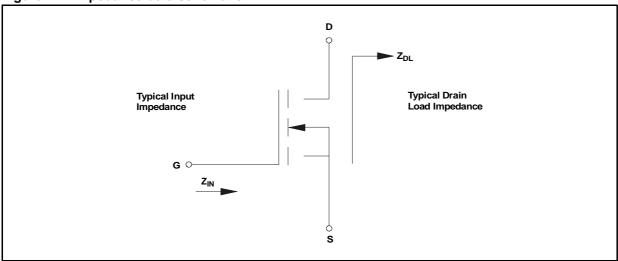


Table 6. Impedance data

f	<b>Z</b> <sub>IN</sub> (Ω)	<b>Z</b> <sub>DL</sub> (Ω)
30 MHz	1.7 - j 5.7	6.8 + j 0.9
175 MHz	1.2 - j 2.0	2.0 + j 2.4

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3 Typical performance SD2941-10

### 3 Typical performance

Figure 2. Capacitance Vs Drain Voltage

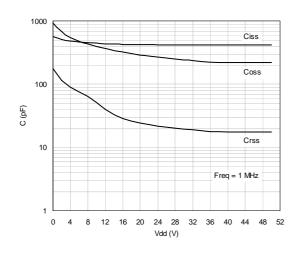


Figure 3. Drain Current Vs Gate Voltage

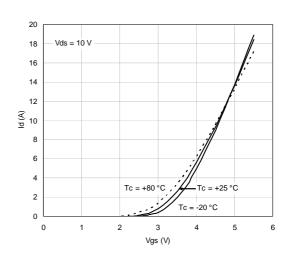
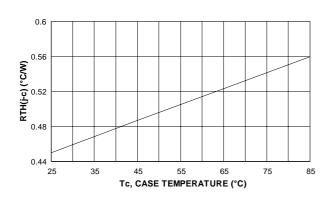
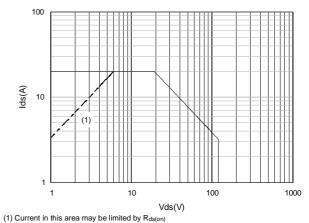


Figure 4. Max. Thermal Resist.Vs Case Temp. Figure 5. Safe Operating Area





SD2941-10 3 Typical performance

Idq = 250mA

100 125 150 175 200 225 250 275

Figure 6. Power Gain Vs Output Power

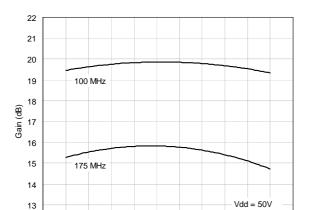


Figure 7. Efficiency Vs Output Power

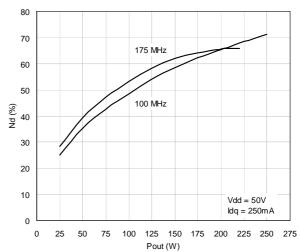
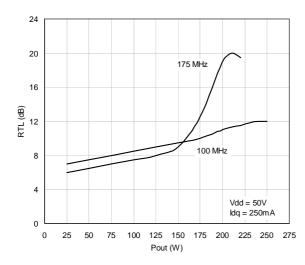


Table 7. Input Return Loss Vs Output Power

Pout (W)



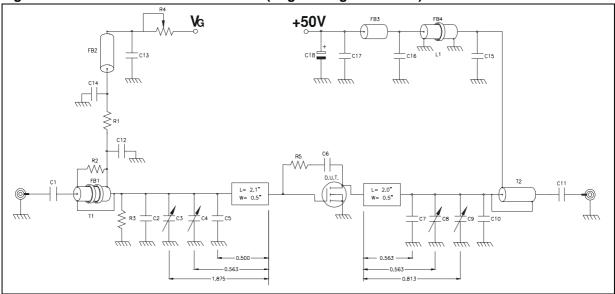
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0 25 50 75

4 Test circuit SD2941-10

### 4 Test circuit

Figure 8. 30 MHz Test circuit schematic (Engineering test circuit)



Note: All dimension are in inches.

Table 8. 30 MHz test circuit component part list

Simbol	Description		
T2	1:4 Transformer, 25Ω Semi-Rigid Coax .141 OD 6" Long		
FB1	Toroid X 2, 0.5" OD .312" ID 850μ 2 Turns		
FB2, FB3	VK200		
FB4	Shield Bead, 1" OD 0.5" ID 850μ 3 Turns		
L1	1/4 Wave Choke, 50Ω Semi-Rigid Coax .141 OD 12" Long		
PCB	0.62" Woven Fiberglass, 1 oz. Copper, 2 Sides, &r = 2.55		
R1, R3	470Ω 1 W Chip Resistor		
R2	360Ω 1/2 W Resistor		
R4	20 KΩ 10 Turn Potentiometer		
R5	560Ω 1 W Resistor		
C1, C11	470 pF ATC Chip Cap		
C2	43 pF ATC Chip Cap		
C3, C8, C9	Arco 404, 12-65 pF		
C4	Arco 423, 16-100 pF		
C5	120 pF ATC Chip Cap		
C6	0.01 μF ATC Chip Cap		
C7	30 pF ATC Chip Cap		
C10	91 pF ATC Chip Cap		
C12, C15	1200 pF ATC Chip Cap		
C13, C14,C16, C17	0.01 μF / 500 V Chip Cap		
C18	10 μF 63 V Electrolytic Capacitor		

SD2941-10 4 Test circuit

Figure 9. 175 MHz test circuit pPhotomaster

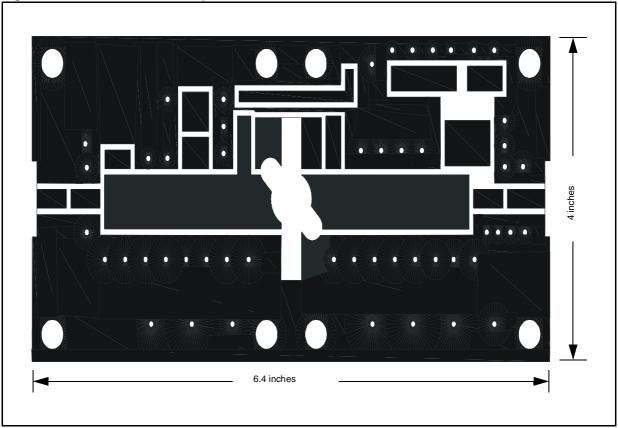
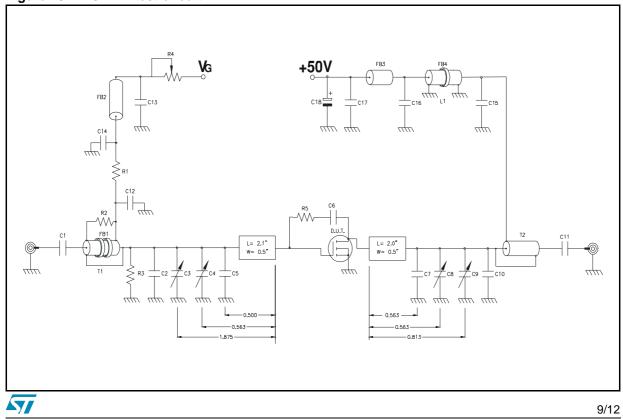


Figure 10. 175 MHz test circuit



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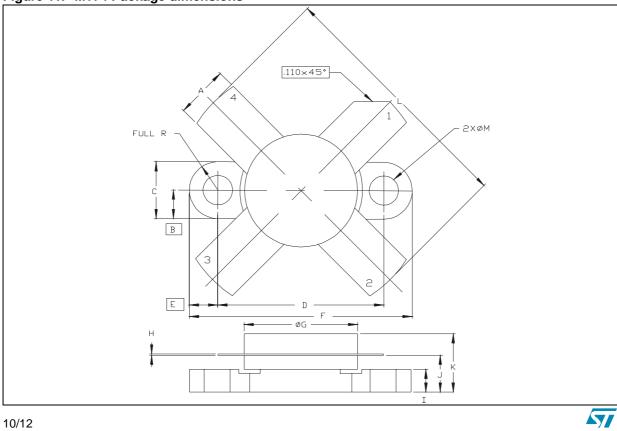
5 Mechanical data SD2941-10

### 5 Mechanical data

Table 9. M174 (.500 DIA 4/L N/HERM W/FLG)

10 0.	11174 (.000 D1		,			
DIM.		mm.			inch	
Diwi.	MIN.	TYP.	MAX	MIN.	TYP.	MAX
Α						
В	5.56		5.584	0.219		0.230
С		3.18			0.125	
D	6.22		6.48	0.245		0.255
E	18.28		18.54	0.720		0.730
F		3.18			0.125	
G	24.64		24.89	0.970		0.980
Н	12.57		12.83	0.495		0.505
I	0.08		0.18	0.003		0.007
J	2.11		3.00	0.083		0.118
K	3.81		4.45	0.150		0.175
L			7.11			0.280
М	25.53		26.67	1.005		1.050





SD2941-10 6 Revision history

# 6 Revision history

Table 10. Revision history

Date	Revision	Changes
15-Nov-2005	1	First Issue
06-Apr-2006	2	Complete version
13-Apr-2006	3	V <sub>DS(ON)</sub> updated

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